R&S®MXO 5 Series OSCILLOSCOPE

Specifications



Mess- und Prüftechnik. Die Experten.

Ihr Ansprechpartner / Your Partner:

dataTec AG

E-Mail: info@datatec.eu >>> www.datatec.eu



Specifications Version 03.00

ROHDE&SCHWARZ

Make ideas real



CONTENTS

Definitions	3
Base unit	4
Vertical system: analog channels	4
Vertical system: digital channels	7
Horizontal system	7
Acquisition system	8
High definition mode	9
Trigger system	9
Spectrum analysis	10
RF characteristics	11
Waveform measurements	12
Waveform math	12
Digital voltmeter	12
Display characteristics	13
History and segmented memory	13
Miscellaneous	14
Input and output	14
General data	15
Options	17
R&S®MXO5-B1 mixed signal option	17
R&S®MXO5-B6 arbitrary waveform generator	17
R&S®MXO5-K31 power analysis	20
R&S®MXO5-K36 frequency response analysis	20
R&S®MXO5-K510 low speed serial buses	20
R&S®MXO5-K520 automotive protocols	22
Ordering information	23

Definitions

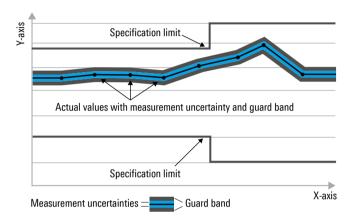
Genera

Product data applies under the following conditions:

- Three hours storage at ambient temperature followed by 60 minutes warm-up operation
- Specified environmental conditions met
- · Recommended calibration interval adhered to
- All internal automatic adjustments performed, if applicable

Specifications with limits

Represent warranted product performance by means of a range of values for the specified parameter. These specifications are marked with limiting symbols such as $\langle , , \rangle$, \geq , \pm , or descriptions such as maximum, limit of, minimum. Compliance is ensured by testing or is derived from the design. Test limits are narrowed by guard bands to take into account measurement uncertainties, drift and aging, if applicable.



Non-traceable specifications with limits (n. trc.)

Represent product performance that is specified and tested as described under "Specifications with limits" above. However, product performance in this case cannot be warranted due to the lack of measuring equipment traceable to national metrology standards. In this case, measurements are referenced to standards used in the Rohde & Schwarz laboratories.

Specifications without limits

Represent warranted product performance for the specified parameter. These specifications are not specially marked and represent values with no or negligible deviations from the given value (e.g. dimensions or resolution of a setting parameter). Compliance is ensured by design.

Typical data (typ.)

Characterizes product performance by means of representative information for the given parameter. When marked with <, > or as a range, it represents the performance met by approximately 80 % of the instruments at production time. Otherwise, it represents the mean value.

Nominal values (nom.)

Characterize product performance by means of a representative value for the given parameter (e.g. nominal impedance). In contrast to typical data, a statistical evaluation does not take place and the parameter is not tested during production.

Measured values (meas.)

Characterize expected product performance by means of measurement results gained from individual samples.

Uncertainties

Represent limits of measurement uncertainty for a given measurand. Uncertainty is defined with a coverage factor of 2 and has been calculated in line with the rules of the Guide to the Expression of Uncertainty in Measurement (GUM), taking into account environmental conditions, aging, wear and tear.

Device settings and GUI parameters are designated with the format "parameter: value".

Non-traceable specifications with limits, typical data as well as nominal and measured values are not warranted by Rohde & Schwarz.

In line with the 3GPP standard, chip rates are specified in million chips per second (Mcps), whereas bit rates and symbol rates are specified in billion bit per second (Gbps), million bit per second (Mbps), thousand bit per second (kpps), million symbols per second (Msps) or thousand symbols per second (kpps), and sample rates are specified in million samples per second (Msample/s). Gbps, Mcps, Msps, ksps, ksps and Msample/s are not SI units.

Base unit

Vertical system: analog channels

Input channels		4 channels or 8 channels	
Input impedance		50 Ω ± 1.5 %,	
		1 MΩ ± 1 % 12 pF (meas.)	
Analog bandwidth (-3 dB)	R&S®MXO 54, 4-channel instrument		
	at 50 Ω input impedance		
	R&S®MXO 5	≥ 350 MHz	
	R&S®MXO 5 with -B245 option	≥ 500 MHz	
	R&S®MXO 5 with -B2410 option	≥ 1 GHz	
	R&S®MXO 5 with -B2420 option	≥ 2 GHz ¹	
	at 1 MΩ input impedance, 4 channels		
	R&S [®] MXO 5	≥ 350 MHz (meas.)	
	R&S®MXO 5 with -B245 option	≥ 500 MHz (meas.)	
	R&S®MXO 5 with -B2410 option	≥ 700 MHz (meas.) ²	
	R&S®MXO 5 with -B2420 option	≥ 700 MHz (meas.) ²	
	R&S®MXO 58, 8-channel instrument		
	at 50 Ω input impedance		
	R&S®MXO 5	≥ 100 MHz	
	R&S®MXO 5 with -B282	≥ 200 MHz	
	R&S®MXO 5 with -B283	≥ 350 MHz	
	R&S®MXO 5 with -B285 option	≥ 500 MHz	
	R&S®MXO 5 with -B2810 option	≥ 1 GHz	
	R&S®MXO 5 with -B2820 option	≥ 2 GHz ³	
	at 1 MΩ input impedance, 4 channels		
	R&S®MXO 5	≥ 100 MHz (meas.)	
	R&S®MXO 5 with -B282	≥ 200 MHz	
	R&S®MXO 5 with -B283	≥ 350 MHz	
	R&S®MXO 5 with -B285 option	≥ 500 MHz (meas.)	
	R&S®MXO 5 with -B2810 option	≥ 700 MHz (meas.) ²	
	R&S®MXO 5 with -B2820 option	≥ 700 MHz (meas.) ²	
Bandwidth limits	max. –1.5 dB, min. –4 dB	2 GHz, 1 GHz, 500 MHz, 350 MHz,	
	,	200 MHz, 100 MHz, 50 MHz, 20 MHz	
		(meas.)	
Rise/fall time (calculated)	10 % to 90 % at 50 Ω		
,	R&S®MXO 54, 4-channel instrument		
	R&S®MXO 5	< 1.75 ns	
	R&S®MXO 5 with -B245 option	< 700 ps	
	R&S®MXO 5 with -B2410 option	< 350 ps	
	R&S®MXO 5 with -B2420 option	< 175 ps	
	R&S®MXO 58, 8-channel instrument	- 1	
	R&S®MXO 5	< 3.5 ns	
	R&S®MXO 5 with -B282	< 1.75 ns	
	R&S®MXO 5 with -B283	< 1 ns	
	. 15.5 15 6 Mail B200		
	R&S®MXO 5 with -B285 option	< 700 ps	
	R&S®MXO 5 with -B285 option R&S®MXO 5 with -B2810 option	< 700 ps < 350 ps	
	R&S®MXO 5 with -B2810 option	< 350 ps	
Vertical resolution	-	< 350 ps < 234 ps	
Vertical resolution	R&S®MXO 5 with -B2810 option	< 350 ps < 234 ps 12 bit,	
	R&S®MXO 5 with -B2810 option R&S®MXO 5 with -B2820 option	< 350 ps < 234 ps 12 bit, 18 bit for high definition (HD) mode	
	R&S®MXO 5 with -B2810 option	< 350 ps < 234 ps 12 bit, 18 bit for high definition (HD) mode 0.5 mV/div to 3 V/div,	
	R&S®MXO 5 with -B2810 option R&S®MXO 5 with -B2820 option	< 350 ps < 234 ps 12 bit, 18 bit for high definition (HD) mode 0.5 mV/div to 3 V/div, entire analog bandwidth supported for all	
	R&S®MXO 5 with -B2810 option R&S®MXO 5 with -B2820 option at 50 Ω	< 350 ps < 234 ps 12 bit, 18 bit for high definition (HD) mode 0.5 mV/div to 3 V/div, entire analog bandwidth supported for all input sensitivities	
Vertical resolution Input sensitivity	R&S®MXO 5 with -B2810 option R&S®MXO 5 with -B2820 option	< 350 ps < 234 ps 12 bit, 18 bit for high definition (HD) mode 0.5 mV/div to 3 V/div, entire analog bandwidth supported for all	

 $^{^{\}rm 1}~$ 2 GHz analog bandwidth in interleave mode with 5 Gsample/s real-time sampling rate.

² With R&S[®]RT-ZP11 passive probe.

^{3 2} GHz analog bandwidth only in interleave mode with 5 Gsample/s real-time sampling rate, when channels 5 to 8 are disabled.

DC gain accuracy	offset and position set to 0 V, after self-alignment		
	input sensitivity > 5 mV/div	±1 % full scale	
	input sensitivity	±1.5 % full scale	
	≤ 5 mV/div to ≥ 1 mV/div		
	input sensitivity 500 μV/div	±2.5 % full scale	
Input coupling	at 50 Ω	DC	
	at 1 MΩ	DC, AC	
Maximum input voltage	at 50 Ω	5 V (RMS), 30 V (V _p)	
-	at 1 MΩ	300 V (RMS), 400 V (V _p),	
		derates at 20 dB/decade to 5 V (RMS)	
		above 250 kHz	
	at 1 MΩ with R&S®RT-ZP11 passive	400 V (RMS), 1650 V (V _p),	
	probe	300 V (RMS) CAT II;	
		for derating and details,	
		see R&S®RT-Zxx Standard Probes	
		specifications (PD 3607.3851.22)	
Position range		±5 div	
Offset range at 50 Ω	input sensitivity		
-	120 mV/div to 3 V/div	±(15 V – input sensitivity × position)	
	33 mV/div to < 120 mV/div	±(7 V – input sensitivity × position)	
	0.5 mV/div to < 33 mV/div	±(2 V – input sensitivity × position)	
Offset range at 1 MΩ	input sensitivity		
	800 mV/div to 10 V/div	±200 V	
	80 mV/div to < 800 mV/div	±50 V	
	0.5 mV/div to < 80 mV/div	±(5 V – input sensitivity × position)	
Offset accuracy		±(0.35 % × net offset +	
•		0.5 mV + 0.1 div × input sensitivity);	
		(net offset =	
		offset – position × input sensitivity)	
DC measurement accuracy	after adequate suppression of	±(DC gain accuracy ×	
-	measurement noise using high definition	reading - net offset	
	(HD) mode or waveform averaging or a	+ offset accuracy)	
	combination of both		
Channel-to-channel isolation	input frequency inside instrument	> 60 dB (1:1000)	
(each channel at same input sensitivity)	bandwidth		

RMS nois	se floor 4						
At 50 Ω	Input	Analog bandwid	dth (-3 dB)				
(meas.)	sensitivity	100 MHz	200 MHz	350 MHz	500 MHz	1 GHz	2 GHz
	0.5 mV/div	19 µV	26 µV	33 µV	39 µV	66 µV	111 µV
	1 mV/div	24 µV	33 µV	42 µV	51 µV	85 µV	141 µV
	2 mV/div	25 µV	35 µV	44 µV	53 µV	89 µV	146 µV
	5 mV/div	34 µV	46 µV	59 µV	71 µV	116 µV	182 µV
	10 mV/div	66 µV	89 µV	115 µV	138 µV	226 µV	350 µV
	20 mV/div	134 µV	181 µV	233 μV	280 µV	461 µV	713 µV
	50 mV/div	324 µV	436 µV	563 µV	677 µV	1.12 mV	1.78 mV
	100 mV/div	610 µV	815 µV	1.05 mV	1.26 mV	2.08 mV	3.25 mV
	200 mV/div	1.26 mV	1.69 mV	2.17 mV	2.60 mV	4.31 mV	6.74 mV
	500 mV/div	4.21 mV	5.54 mV	6.94 mV	8.21 mV	12.93 mV	18.63 mV
	1 V/div	6.88 mV	9.20 mV	11.71 mV	14.02 mV	22.57 mV	32.89 mV
	2 V/div	11.45 mV	15.21 mV	19.45 mV	23.21 mV	37.85 mV	54.59 mV
	3 V/div	15.77 mV	20.78 mV	26.54 mV	31.71 mV	51.80 mV	73.68 mV
At 1 MΩ	Input	Analog bandwid	dth (-3 dB)		'		
(meas.)	sensitivity	100 MHz	200 MHz	350 MHz	500 MHz	700 MHz	
	0.5 mV/div	35 µV	40 μV	46 µV	54 μV	85 µV	
	1 mV/div	36 µV	42 µV	49 µV	57 μV	89 µV	
	2 mV/div	38 µV	45 µV	54 µV	64 µV	101 µV	
	5 mV/div	47 μV	58 μV	77 μV	92 μV	141 µV	
	10 mV/div	68 µV	89 µV	126 μV	152 μV	229 µV	
	20 mV/div	120 μV	161 μV	235 µV	285 µV	428 μV	
	50 mV/div	297 μV	401 μV	592 μV	719 µV	1.08 mV	
	100 mV/div	678 μV	892 µV	1.25 mV	1.47 mV	2.16 mV	
	200 mV/div	1.21 mV	1.62 mV	2.33 mV	2.77 mV	4.09 mV	
	500 mV/div	2.88 mV	3.88 mV	5.68 mV	6.76 mV	10.01 mV	
	1 V/div	6.11 mV	8.08 mV	11.54 mV	13.56 mV	18.51 mV	
	2 V/div	11.42 mV	15.20 mV	22.04 mV	25.98 mV	35.39 mV	
	5 V/div	29.10 mV	38.75 mV	56.46 mV	66.60 mV	90.40 mV	
	10 V/div	44.33 mV	58.62 mV	85.77 mV	101.12 mV	137.86 mV	

⁴ HD mode active for bandwidth ≤ 500 MHz.

Vertical system: digital channels

Input channels		16 logic channels (D0 to D15)
Arrangement of input channels		arranged in two logic probes with
		8 channels each, assignment of the logic
		probes to the channels (D0 to D7 and D8
		to D15) is displayed on the probe
Input impedance		100 kΩ ± 2 % ~4 pF (meas.) at probe
		tips
Maximum input frequency	signal with minimum input voltage swing	400 MHz (meas.)
	and hysteresis setting: normal	
Maximum input voltage		±40 V (V _p)
Minimum input voltage swing		500 mV (V _{pp}) (meas.)
Threshold groups		D0 to D3, D4 to D7, D8 to D11 and
		D12 to D15
Threshold level	range	±8 V in 25 mV steps
	predefined	CMOS 5.0 V, CMOS 3.3 V, CMOS 2.5 V,
		TTL, ECL, PECL, LVPECL
Threshold accuracy	threshold level between ±4 V	±(100 mV + 3 % of threshold setting)
Comparator hysteresis		normal, robust, maximum

Horizontal system

Timebase range		selectable between 200 ps/div and
		10000 s/div,
		time per div settable to any value within
		range
Deskew range (channel deskew)	between analog channels	±100 ns
	between digital channels	±100 ns
Reference position	-	0 % to 100 % of measurement display
		area
Horizontal position range (trigger offset	max.	+(memory depth/current sampling rate)
range)	min.	–5000 s
Modes		normal
Channel-to-channel skew	between analog channels	< 100 ps (meas.)
	between digital channels	< 500 ps (meas.)
Timebase accuracy	after delivery/calibration, at +23 °C	±0.2 ppm
	during calibration interval	±1 ppm
Delta time accuracy	corresponds to time error between two	±(0.20/real-time sampling rate +
	edges on same acquisition and channel;	timebase accuracy × reading) (peak)
	signal amplitude greater than 5 divisions,	(meas.)
	measurement threshold set to 50 %,	
	vertical gain 10 mV/div or greater;	
	rise time lower than four sample periods;	
	waveform acquired in real-time mode	

Acquisition system

Sampling rate	analog channels (real time)	max. 5 Gsample/s on 4 channels, max. 2.5 Gsample/s on 8 channels
	analog channels (interpolated)	max. 5 Tsample/s
	digital channels	max. 5 Gsample/s on each channel
Waveform acquisition rate	max.	> 4 500 000 waveforms/s
Trigger rearm time	min.	< 21 ns
Memory depth ⁵	standard	
	analog channels only	R&S®MXO 58, 8-channel instrument: max. 500 Mpoints with 8 active channels (single capture), max. 500 Mpoints with 4 active channels (run continuous); R&S®MXO 54, 4-channel instrument: max. 500 Mpoints (single capture and run continuous)
	digital channels only (MSO)	max. 500 Mpoints with 16 digital channels (single capture), max. 500 Mpoints with 8 digital channels (run continuous)
	mix analog and digital	max. 500 Mpoints with 2 analog and 8 digital channels (single capture), max. 250 Mpoints with 2 analog and 8 digital channels (run continuous)
	with R&S®MXO5-B110 memory option 1 (Gpoints
	analog channels only	max. 1 Gpoints with 4 active channels (single capture), max. 1 Gpoints with 2 active channels (run continuous)
	digital channels only (MSO)	max. 1 Gpoints with 8 digital channels (single capture), max. 500 Mpoints with 8 digital channels (run continuous)
	mix analog and digital	max. 500 Mpoints with 2 analog and 8 digital channels (single capture), max. 250 Mpoints with 2 analog and 8 digital channels (run continuous)
	math	
	with 1 active math	max. 87.5 Mpoints
	with 2 active math	max. 42.5 Mpoints
	with 2 active math	max. 20 Mpoints
	with 2 active math	max. 10 Mpoints
Acquisition modes	sample peak detect	middle sample in decimation interval largest and smallest sample in decimation interval
	average	average value of samples in decimation interval
	number of averaged waveforms	2 to 16 777 215
	envelope	envelope of acquired waveforms
Sampling modes	real-time mode	max. sampling rate set by digitizer
	interpolated time	enhancement of sampling resolution by interpolation; max. sampling rate is 5 Tsample/s
Interpolation modes		linear, sin(x)/x, sample & hold
Fast segmentation mode	continuous recording of waveforms in acq visualization	uisition memory without interruption due to
	max. real-time waveform acquisition rate	> 4 600 000 waveforms/s
	min. blind time between consecutive acquisitions	< 21 ns

_

The maximum available memory depth depends on the bit resolution of the acquired data and, therefore, on the acquisition system settings such as decimation mode, use of waveform arithmetics or high definition (HD) mode. Interleave channels of the R&S®MXO 58 are on C1 and C5, C2 and C6, C3 and C7 as well as C4 and C8. For the R&S®MXO 54, all 4 channels run with 5 Gsample/s and maximum bandwidth.

High definition mode

General description	digital filtering, leading to reduced n	The high definition mode increases the bit resolution of the waveform signal by using digital filtering, leading to reduced noise. Because of the digital trigger concept of the R&S®MXO 5, signals with increased numeric resolution are used as the input for triggering.	
Numeric resolution	bandwidth, at 5 Gsample/s	bit resolution	
	1 kHz to 10 MHz	18 bit	
	100 MHz	16 bit	
	200 MHz	15 bit	
	500 MHz	14 bit	
Real-time sampling rate	all models	max. 2.5 Gsample/s on 4 channels,	
		max. 1.25 Gsample/s on 8 channels	

Trigger system

Trigger sources		analog channels (C1 to C8),
		digital channels (D0 to D15),
		trigger input, line trigger, serial bus
Trigger level range		±5 div from center of screen
Trigger modes		auto, normal, single, n single
Trigger sensitivity		0.0001 div, from DC to instrument
		bandwidth for all vertical scales, user
		adjustable
Trigger jitter	full-scale sine wave of frequency set to	< 1 ps (RMS) (meas.)
	−3 dB bandwidth	
Coupling mode	standard	same as selected channel
	HF reject	cutoff frequency selectable from 1 kHz to
		500 MHz
	LF reject	attenuates frequencies < 50 kHz
Trigger hysteresis	modes	auto (default setting) or manual
	adjustment resolution	0.0001 div, from DC to instrument
		bandwidth for all vertical scales
Holdoff range	time	100 ns to 10 s, fixed and random

Main trigger modes				
Edge	triggers on specified edge (positive	triggers on specified edge (positive, negative or either) and level		
Glitch	triggers on glitches of positive, nega	triggers on glitches of positive, negative or either polarity that are shorter or longer than specified width		
	glitch width	200 ps to 1000 s		
Width	triggers on positive or negative puls inside or outside a specified range	se of specified width; width can be shorter, longer,		
	pulse width	200 ps to 1000 s		
Runt	triggers on pulse of positive, negative	ve or either polarity that crosses one threshold but		
	fails to cross a second threshold be	fails to cross a second threshold before crossing the first one again; runt pulse width		
	can be arbitrary, shorter, longer, ins	can be arbitrary, shorter, longer, inside or outside a specified range		
	runt pulse width	200 ps to 1000 s		
Window		triggers when signal enters or exits a specified voltage range; triggers also when signal stays inside or outside the voltage range for a specified period of time		
Timeout	triggers when signal stays high, low	triggers when signal stays high, low or unchanged for a specified period of time		
	timeout	0 ps to 1000 s		
Interval	triggers when time between two con	triggers when time between two consecutive edges of same slope (positive or		
	negative) is shorter, longer, inside of	or outside a specified range		
	interval time	200 ps to 1000 s		
Slew rate	triggers when the time required by a	triggers when the time required by a signal edge to toggle between user-defined upper		
	and lower voltage levels is shorter,	and lower voltage levels is shorter, longer, inside or outside a specified range; edge		
	. , ,	slope may be positive, negative or either		
	toggle time	0 ps to 1000 s		

Advanced trigger modes					
Serial bus trigger	optional	see dedicated triggering and decoding options			
Trigger input	input impedance	50Ω (meas.) or 1 MΩ (meas.) 11 pF (meas.)			
	max. input voltage at 50 Ω	30 V (V _p)			
	max. input voltage at 1 M Ω	300 V (RMS), 400 V (V _p), derates at 20 dB/decade to 5 V (RMS) above 250 kHz			
	trigger level	±5 V			
	sensitivity	sensitivity			
	input frequency ≤ 500 MHz	300 mV (V _{pp}) (meas.)			
	input coupling	AC, DC (50 Ω and 1 M Ω)			
	trigger filter	HF reject (attenuates > 50 kHz), LF reject (attenuates < 50 kHz), noise reject			
	trigger modes	edge (positive, negative or either)			
Trigger output	functionality	A pulse is generated for each event triggering signal acquisition.			
	output voltage	0 V to 5 V (nom.) at high impedance; 0 V to 2.5 V (nom.) at 50 Ω			
	pulse width	selectable between 16 ns and 50 ms			
	pulse polarity	low active or high active			
	output delay	depends on trigger settings			

Spectrum analysis

General description	Spectrum analysis allows up to four signal	Spectrum analysis allows up to four signal analysis in the frequency domain.		
Spectrum	sources	channel 1 to channel 8		
	setup parameters	center frequency, frequency span,		
		resolution bandwidth (automatic or		
		manual), gate position, gate width, vertical		
		scaling, vertical position		
	scaling	dBm, dBV, dBµV, V (RMS)		
	span	1 Hz to 1.8 GHz ⁶		
	resolution bandwidth (RBW)	(span/4) ≥ RBW ≥ (span/6000)		
	windows	flat top, Hanning, Hamming, Blackman,		
		rectangular, Kaiser Bessel, Gaussian		
	trace types	normal, max. hold, min. hold, average		
	max. real-time waveform acquisition rate	max. real-time waveform acquisition rate > 40 000 waveforms/s		
Gate	delimits the display region used for spectru	delimits the display region used for spectrum analysis		
Peak list	The values in the peak list are also shown	The values in the peak list are also shown in the diagram to allow easy correlation.		

 $^{^{\}rm 6}$ $\,$ The stop frequency depends on the analog bandwidth of the instrument.

RF characteristics

Sensitivity/noise density	at 1 GHz (measurement of the power spectral density at 1 GHz at input sensitivity 2 mV/div, corresponding to –30 dBm input range of the oscilloscope, using spectrum analysis with center frequency 1 GHz, span 500 kHz, RBW 3 kHz)	-160 dBm (1 Hz) (meas.)
Noise figure	at 1 GHz (calculated based on the noise power density above)	14 dB (meas.)
Dynamic range	measured for a 1 GHz input carrier with level –3 dBm at input of oscilloscope, using spectrum analysis with center frequency 1 GHz, span 2 MHz, RBW 400 Hz at +20 MHz from center frequency	106 dB (meas.)
Absolute amplitude accuracy	0 Hz to 1.2 GHz	±1 dB (meas.)
Spurious-free dynamic range (excluding harmonics)	measured for a 250 MHz input carrier with level –3 dBm at input sensitivity 50 mV/div, using spectrum analysis with center frequency 900 MHz, span 1.8 GHz, RBW 300 kHz	65 dBc (meas.)
Second harmonic distortion	measured for a 250 MHz input carrier with level –3 dBm at input sensitivity 50 mV/div, using spectrum analysis with center frequency 900 MHz, span 1.8 GHz, RBW 300 kHz	-60 dBc (meas.)
Third harmonic distortion	measured for a 250 MHz input carrier with level –3 dBm at input sensitivity 50 mV/div, using spectrum analysis with center frequency 900 MHz, span 1.8 GHz, RBW 300 kHz	–59 dBc (meas.)

Waveform measurements

Automatic measurements	measurements on acquired waveforms (input channels), math waveforms, reference waveforms	amplitude, high, low, maximum, minimum, peak-to-peak, mean, RMS, sigma, positive overshoot, negative overshoot, area, rise time, fall time, positive pulse width, negative pulse width, period, frequency, positive duty cycle, negative duty cycle, delay, phase, burst width, pulse count, edge count, pulse train, positive switching, negative switching, cycle area, cycle mean, cycle RMS, cycle sigma, setup, hold, setup/hold time, setup/hold ratio, slew rate rising, slew rate falling, delay to trigger
	gate	delimits the display region evaluated for automatic measurements
	reference levels	user-configurable vertical levels define support structures for automatic measurements
	statistics	displays maximum, minimum, mean, standard deviation and measurement count for each automatic measurement
	number of active measurements	24
Cursor measurements	available cursors	up to four cursor sets on screen, each set with two horizontal and two vertical cursors
	target waveforms	acquired waveforms (input channels), math waveforms, reference waveforms, XY diagrams
	operating modes	vertical measurements, horizontal measurements, or both; vertical cursors either set manually or locked to waveform

Waveform math

General features	number of math equations	up to 8
	number of reference waveforms	up to 8
	sources	channel 1 to 8, math waveforms 1 to 8, reference waveforms 1 to 8
Functions	operators	add, subtract, multiply, divide, absolute value, square, square root, integrate, differentiate, log ₁₀ , log _e , log ₂ , reciprocal, invert, lowpass, highpass, rescale (a · x + b)
	filters	lowpass, highpass
	filter types	Gaussian, rectangular
	gate	delimits the display region used for waveform math

Digital voltmeter

Accuracy		related to channel settings of voltmeter
		source
Measurements		DC, DC RMS, AC RMS
Sources	R&S®MXO 54	C1, C2, C3, C4
	R&S®MXO 58	C1, C2, C3, C4, C5, C6, C7, C8
Number of measurements		up to 4
Resolution		up to 6 digits
Bandwidth		up to 20 MHz

Display characteristics

Diagram types	Yt, zoom, spectrum
Display configuration (waveform	The display area can be split into separate diagram areas by dragging and dropping signal
layout)	icons. Each diagram can hold any number of signals. Diagrams can be stacked on top of each other and later accessed via dynamic tabs (Tab 1, etc.)
Signal icons	Each active waveform is represented by a signal icon on the signal bar; the signal icon displays the individual vertical and acquisition settings.
Toolbar	Enables quick access to important tools; allows to set the most common parameters directly in a simple menu and gives access to more detailed parameters in the main menu. User-defined selection of tools in the toolbar.
Upper menu bar	Displays trigger, horizontal and acquisition system settings; allows quick access to these settings.
Main menu	Provides access to all instrument settings in a compact menu structure.
Axis label	The x-axis and y-axis are labeled with values and physical unit.
Diagram label	Diagrams can be individually labeled with a descriptive, user-defined name.
Diagram layout	The grid, crosshair, axis labeling and diagram labeling can be switched on and off separately.
Persistence	50 ms to 50 s, or infinite
Zoom	vertical and horizontal; touch interface simplifies resize and drag operations on zoom window
Signal colors (waveform coding)	predefined or user-defined color tables for persistence display

History and segmented memory

Acquisition memory	automatic	automatic setting	of segment size and s	ample rate	
	manual	user-defined sett	ing of segment size an	d sample rate	
Memory segmentation	function	memory segments for the acquisition			
	number of segments	record length	segments ⁷ (up to)	total memory	
		1 kpoints	1 048 575	1.049 Gpoints	
		2 kpoints	1 048 575	2.097 Gpoints	
		5 kpoints	1 048 575	5.243 Gpoints	
		10 kpoints	1 048 575	10.486 Gpoints	
		20 kpoints	1 048 575	20.972 Gpoints	
		50 kpoints	1 048 575	52.429 Gpoints	
		100 kpoints	1 048 575	104.858 Gpoints	
		200 kpoints	1 048 575	209.715 Gpoints	
		500 kpoints	1 048 575	524.288 Gpoints	
		1 Mpoints	1 048 575	1048.575 Gpoints	
		2 Mpoints	524 287	1048.574 Gpoints	
		5 Mpoints	262 143	1310.715 Gpoints	
		10 Mpoints	131 071	1310.710 Gpoints	
		20 Mpoints	65 535	1310.700 Gpoints	
		50 Mpoints	32 767	1638.350 Gpoints	
		100 Mpoints	16 383	1638.300 Gpoints	
		200 Mpoints	9 361	1872.200 Gpoints	
		500 Mpoints	4 095	2047.500 Gpoints	
		1 Gpoints	2 113	2113.000 Gpoints	
	Segmentation is available for all analog and logic channels, protocol decoding and spectrum analysis.				
Fast-segmented mode			quisition memory witho ecutive acquisitions, se	ee Acquisition system	
History mode	function		provides access t	The history mode is an always-on function and provides access to past acquisitions in the	
	timestamp resolution	timestama resolution		segmented memory. 1 ns	
	•	timestamp resolution		replays the recorded waveforms; repetition	
	flistory player	history player		possible; adjustable speed; manual switching to	
			, ,	ment; numerical segment	
	analyze options			ents, average all segments,	

With R&S®MXO5-B110 memory option. The maximum number of segments depends on the number of active channels and the bit resolution of the acquired data and, therefore, on the acquisition system settings such as decimation mode, use of waveform arithmetics or high definition (HD) mode. The maximum number of segments without the R&S®MXO5-B110 memory option is limited to 10 000.

Miscellaneous

Remote control	web interface	full operation of the instrument's touch
		interface, keys and multifunction wheel via web browser
	VNC	control of the instrument through virtual network computing
	SCPI	standard instrument programming interface through VISA
	WebDAV	support for the web distributed authoring and versioning (WebDAV) protocol, which provides secure access through an application proxy
Languages	available languages for the user interface	English, German, French, Simplified Chinese, Traditional Chinese, Japanese, Russian, Spanish, Italian, Portuguese, Korean, Czech, Polish
	online help on the instrument	English

Input and output

Front		
Channel inputs		BNC; for details, see Vertical system
	probe interface	auto detection of passive probes,
		Rohde & Schwarz active probe interface
Trigger input		BNC; for details, see Trigger system
	probe interface	auto detection of passive probes
Waveform generator outputs		BNC; for details, see R&S®MXO5-B6,
(requires R&S®MXO5-B6 option)		waveform generator,
		demo lugs and GND lug
Digital channel inputs	D15 to D8, D7 to D0	interface for R&S®RT-ZL04 logic probe
Probe compensation output	signal shape	rectangle, V _{low} = 0 V, V _{high} = 3.3 V
, ,		amplitude 3.3 V $(V_{pp}) \pm 5\%$ (meas.)
	frequency	1 kHz ± 1 % (meas.)
USB interfaces		3 × USB 3.1 Gen 1 ports, type A plug

Rear		
Trigger out		BNC;
		for details, see Trigger system
USB interface		1 × USB 3.1 Gen 1 port, type B plug
Reference input	connector	BNC
	impedance	50 Ω (nom.)
	input frequency	10 MHz (±20 ppm)
	sensitivity	\geq -10 dBm into 50 Ω ,
		≤ 10 dBm at 10 MHz
Reference output	connector	BNC
	impedance	50 Ω (nom.)
	output signal	10 MHz (specified with timebase
		accuracy), 8 dBm (nom.)
Security slot		for standard Kensington style lock
VESA mount	via R&S®MXO5-Z7 VESA adapter	VESA compatibility mounting interface,
		100 mm × 100 mm pattern size, according
		FDMI MIS-D, up to 14 kg with M4x10
		screws

Right side		
Ground jack	connected to ground	
USB interfaces	2 × USB 3.1 Gen 1 ports, type A plug	
LAN interface	RJ-45 connector,	
	supports 10/100/1000BASE-T	
External monitor interface	HDMI™ 2.0 and DisplayPort++ 1.3,	
	output of oscilloscope display	

General data

Display	type	15.6" LC TFT color display with capacitive
		touchscreen
	resolution	1920 × 1080 pixel (Full HD)

Temperature		
Temperature range	operating temperature range	0 °C to +50 °C
	storage temperature range	–40 °C to +70 °C
		in line with MIL-PRF-28800F section
		4.5.5.1.1.1 class 3 tailored to +45 °C for
		operation
Climatic resistance	damp heat	+25 °C/+50 °C at 85 % relative humidity
		cyclic,
		in line with IEC 60068-2-30

Altitude	
Operating	up to 3000 m above sea level
Nonoperating	up to 4600 m above sea level

Mechanical resistance		
Vibration	sinusoidal	5 Hz to 150 Hz, max. 1.8 g at 55 Hz;
		0.5 g from 55 Hz to 150 Hz,
		in line with EN 60068-2-6
		10 Hz to 55 Hz,
		in line with MIL-PRF-28800F, section
		4.5.5.3.2, class 3
	random	8 Hz to 500 Hz,
		acceleration 1.2 g (RMS),
		in line with EN 60068-2-64
		5 Hz to 500 Hz,
		acceleration 2.058 g (RMS),
		in line with MIL-PRF-28800F,
		section 4.5.5.3.1, class 3
Shock		40 g shock spectrum,
		in line with MIL-STD-810G,
		method no. 516.6, procedure I
		30 g functional shock, half sine,
		duration 11 ms,
		in line with MIL-PRF-28800F,
		section 4.5.5.4.1

Electromagnetic compatibility (EMC)	
RF emissions	in line with CISPR 11/EN 55011 group 1,
	class A (for a shielded test setup);
	the instrument complies with the emission
	requirements stipulated by EN 55011,
	EN 61326-1 and EN 61326-2-1 class A,
	making the instrument suitable for use in
	industrial environments
Immunity	in line with IEC/EN 61326-1 table 2,
	immunity test requirements for industrial
	environment 8

Certifications	VDE, _C CSA _{US} , KC
Calibration interval	1 year

 $^{^{8}~}$ Test criterion is displayed noise level within $\pm 1~{\rm div}$ for an input sensitivity of 5 mV/div.

Version 03.00, October 2023

Power supply		
AC supply		100 V to 240 V ± 10 % at
		50 Hz to 60 Hz and 400 Hz ± 5 %,
		max. 4 A to 1.4 A,
		in line with MIL-PRF 28800F, section 3.5
Power consumption	standby mode	1.6 W
	all channels on	180 W (typ.)
	max.	360 W
Safety		in line with IEC 61010-1,
		IEC 61010-2-030,
		CAN/CSA-C22.2 no. 61010-1-12,
		UL 61010-1,
		CAN/CSA C22.2 no. 61010-2-030-18

Mechanical data		
Dimensions	W×H×D	445 mm × 314 mm × 153 mm
		(17.51 in × 12.36 in × 6.02 in)
Weight	without options, nominal	9.0 kg (19.85 lb)
Rackmount height	with R&S®ZZA-MXO5 rackmount kit	8 HU

Options

R&S®MXO5-B1 mixed signal option

Mixed signal capability is a standard functionality of the R&S®MXO 5 Series oscilloscopes. The R&S®MXO5-B1 mixed signal option provides 16 digital channels with two R&S®RT-ZL04 probes.

R&S®MXO5-B6 arbitrary waveform generator

Arbitrary function/waveform generator, 2 analog channels

General	
Output channel	2 channels
Vertical resolution	16 bit
Operating modes	function generator, arbitrary waveform generator, modulation, frequency sweep

Function generator	output of predefined waveforms	
Sample rate	625 Msample/s	
Waveforms	sine, square/pulse, ramp, DC, noise, sine cardinal (sinc), Gaussian pulse, Lorentz, exponential fall, exponential rise, cardiac	
Sine	frequency range	1 mHz to 100 MHz
	amplitude flatness (relative to 1 kHz)	≤ ±0.5 dB (meas.)
	total harmonic distortion (into 50 Ω)	
	f ≤ 10 MHz	≤ –60 dBc (meas.)
	f > 10 MHz	≤ –40 dBc (meas.)
	nonharmonic spurious	-75 dBc (meas.)
Square/pulse	frequency range	1 mHz to 30 MHz
	duty cycle (if pulse width limit is not exceeded)	0.01 % to 99.99 %, 0.01 % resolution
	pulse width	≥ 16.5 ns, 0.1 ns resolution
	rise/fall time	9 ns (meas.)
	overshoot	≤ 2 % (meas.)
	jitter (cycle-to-cycle) (≥ 0.2 V (V _{pp}))	≤ 40 ps (RMS) (meas.)
Ramp (triangle, sawtooth)	frequency range	1 mHz to 1 MHz
	variable symmetry	0 % to 100 %, 0.1 % resolution
DC	level range	
	into 50 Ω	± 2.5 V
	into open circuit	± 5 V
	resolution	1 mV
Noise	amplitude	
	DC	0 V to 5 V (V_{pp}) (into 50 Ω),
		0 V to 10 V (V _{pp}) (into open circuit),
		1 mV resolution
	all other waveforms	0 % to 100 % of AC signal amplitude, 1 % resolution
	bandwidth	≥ 100 MHz
Sine cardinal (sinc)	frequency range	1 mHz to 5 MHz
Gaussian pulse	frequency range	1 mHz to 25 MHz
Lorentz	frequency range	1 mHz to 10 MHz
Exponential rise/fall	frequency range	1 mHz to 10 MHz
Cardiac	frequency range	1 mHz to 1 MHz

Arbitrary waveform generator	output of user-defined waveforms	
Waveform length	·	1 sample to 40 Msample on each channel
Sample rate		1 sample/s to 312.5 Msample/s
Filter bandwidth		100 MHz
Modulation		
Modulation types		amplitude modulation (AM), frequency modulation (FM), frequency-shift key modulation (FSK), pulse width modulation (PWM)
Carrier waveform	AM, FM, FSK	sine
	PWM	square/pulse
AM	modulation signals	sine, square, ramp (triangle, sawtooth)
	modulation frequency	1 mHz to 1 MHz
	depth	0 % to 100 %, 0.1 % resolution
FM	modulation signals	sine, square, triangle, ramp, inverse ramp
	modulation frequency	1 mHz to 1 MHz
	frequency deviation	1 mHz to 10 MHz
FSK	modulation signal	50 % duty cycle square wave
	range of frequency 1, frequency 2	1 mHz to 100 MHz
	hop rate	1 mHz to 1 MHz
PWM	modulation signals	sine, square, ramp
	depth	0 % to 99.99 % of the duty cycle,
		0.01 % resolution

Frequency sweep	output of a sinusoidal waveform with the frequency changing linearly between the start frequency and the stop frequency within the sweep time	
	waveform sine	
	frequency range	1 mHz to 100 MHz
	direction	up (start frequency < stop frequency)
		down (start frequency > stop frequency)
	sweep time	1 ms to 500 s

Two-channel operation	operating modes	independent channels, coupled parameters, differential
	parameter coupling	none, frequency and/or amplitude
	relative phase	-180° to 180°, 0.1° resolution
	channel-to-channel skew (each channel	≤ 200 ps (meas.)
	with same output amplitude)	
	channel-to-channel isolation	≥ 70 dB (meas.)
	(each channel with same output	
	amplitude)	

Outputs			
Connectors		BNC; on the front of the instrument	
Function		on/off, inverted	
Output impedance		50 Ω (nom.)	
Overload protection	V _{pp} > 200 mV into open circuit	a short-circuit to ground is tolerated indefinitely, automatic shutoff in case of voltages ≥ +12 V or ≤ −12 V (meas.)	
	V _{pp} ≤ 200 mV into open circuit	a short-circuit to ground is tolerated indefinitely, automatic shutoff in case of voltages ≥ +4 V or ≤ -4 V (meas.)	
Amplitude range ⁹	sine, square/pulse, ramp, exponentia	l rise/fall, arbitrary waveforms, sine cardinal (sinc	
	Gaussian, Lorentz, cardiac		
	into 50 Ω	5 mV to 5 V (V _{pp})	
	into open circuit	10 mV to 10 V (V _{pp})	
	resolution	1 mV	
	accuracy	±1 % at 1 kHz	
DC offset range	sine, square/pulse, ramp, exponentia	sine, square/pulse, ramp, exponential rise/fall, arbitrary waveforms	
	into 50 Ω	$\pm 2.5 \text{ V (V}_{pp} > 100 \text{ mV)},$ $\pm 1.25 \text{ V (V}_{pp} \le 100 \text{ mV)}$	
	into open circuit	$\pm 5.0 \text{ V (V}_{pp} > 200 \text{ mV)},$ $\pm 2.5 \text{ V (V}_{pp} \le 200 \text{ mV)}$	
	sine cardinal (sinc): DC offset range is signal amplitude dependent		
	into 50 Ω	-2.823 V to +2.177 V (V _{pp} = 1 V)	
	into open circuit	-5.323 V to +4.677 V (V _{pp} = 1 V)	
	·	Gaussian, Lorentz: DC offset range is signal amplitude dependent	
	into 50 Ω	-3.000 V to +2.000 V (V _{pp} = 1 V)	
	into open circuit	-5.500 V to +4.500 V (V _{pp} = 1 V)	
	·	cardiac: DC offset range is signal amplitude dependent	
	into 50 Ω	-2.814 V to +2.186 V (V _{pp} = 1 V)	
	into open circuit	-5.314 V to +4.686 V (V _{DD} = 1 V)	
	resolution	1 mV	
	accuracy	±(1 % of control + (0.5 % of amplitude) + 2 mV)	
Frequency accuracy		Δf ≤ [(timebase accuracy) × (nominal frequency) + 1.1 μHz] (calc.) (timebase accuracy, see Horizontal system)	

⁹ Amplitude is the sum of the AC amplitude and the noise amplitude.

R&S®MXO5-K31 power analysis

Power analysis (requires R&S®MX	O5-K31 option)			
General description	measurement functionality for DC/DC converters.	The R&S®MXO5-K31 power analysis option extends the R&S®MXO 5 firmware with measurement functionality focused on switched mode power supplies (SMPS) and DC/DC converters. Up to six sets of power analysis measurements are possible.		
Input	quality	evaluation of power quality at an AC input; measures real power, apparent power, reactive power, power factor and phase angle of power, frequency, crest factor, RMS of voltage and current		
	harmonics	measures up to the 334th harmonic of the incoming line frequency; precompliance checking for IEC 61000-3-2 (A, B, C, D), RTCA DO-160, MIL-STD-1399, max. limit checks		
Deskew	automated	automated compensation of the propagation delay		
Zero offset	automated	automatic compensation of input offset		

R&S®MXO5-K36 frequency response analysis

Frequency response analysis (re	equires R&S®MXO5-B6 option)	
Stimulus	frequency mode	single sweep or repeated sweep
	frequency range	10 mHz to 100 MHz
	amplitude mode	fixed or amplitude profile
	amplitude level	10 mV to 10 V into high Z
		5 mV to 5 V into 50 Ω
Input and output sources		channel 1, channel 2, channel 3,
·		channel 4
Number of test points		10 points to 500 points per decade
Measurement		dual pair of tracking gain and phase
		cursors
Diagram types	manually changeable vertical window size	parallel display of result window and input
		and output signal view
Result table		navigation and export functions
Scaling	during and after test	auto scale and manual scaling and
		positioning

R&S®MXO5-K510 low speed serial buses

I ² C decoding		
Protocol configuration	bit rate	auto detected
Trigger	source (clock and data)	any input channel or logical channel
	trigger event setup	start, stop, restart, missing ACK, address,
		data, address + data
	address setup	7 bit or 10 bit address (value in hex or
		binary); read, write or either;
		condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 8 byte (hex or binary);
		condition =, ≠; offset within frame in range
		from 0 byte to 4095 byte
Decode	source (clock and data)	any input channel, logical channel
	display type	decoded bus, tabulated list
	color coding	frame, start/restart, address (read/write),
		data, ACK/NACK, stop, error
	address and data format	hex, decimal, octal, binary, ASCII

SPI decoding		
Protocol configuration	type	2-wire, 3-wire and 4-wire SPI
	bit rate	auto detected
	bit order	LSB first, MSB first
	word size	4/8/12/16/20/24/28/32 bit
	frame condition	CS, timeout
	polarity (MOSI, MISO, CS, CLK)	active high, active low
	phase (CLK)	first edge, second edge
Trigger	source (MOSI, MISO, CS, CLK)	any input channel or logical channel
	bit rate	up to 50 Mbps
	trigger event setup	start of frame, end of frame, MOSI, MISO
	data setup	data pattern up to 32 bit (hex or binary);
		condition =, ≠; offset within frame in range
		from 0 bit to 4095 bit
Decode	source (MOSI, MISO, CS, CLK)	any input channel, logical channel
	display type	decoded bus, tabulated list
	color coding	frame, word, error
	data format	hex, decimal, octal, binary, ASCII

UART/RS-232/RS-422/RS-485 d	ecoding	
Protocol configuration	bit rate	300 bps to 20 Mbps
	signal polarity	idle low, idle high
	number of bits	5 bit to 9 bit
	bit order	LSB first, MSB first
	parity	odd, even, mark, space, none
	stop bit	1, 1.5 or 2
	end of packet	timeout, none
Trigger	source (TX and RX)	any input channel or logical channel
	trigger event setup	start bit, packet start, data, parity error,
		stop error, break condition
	data setup	data pattern (hex, decimal, octal, binary or
		ASCII); condition =, ≠; offset within packet
		in range 0 word to 4095 words
Decode	source (TX and RX)	any input channel, logical channel
	display type	decoded bus, tabulated list
	color coding	packet, data payload, start error, parity
		error, stop error
	data format	hex, decimal, octal, binary, ASCII

R&S®MXO5-K520 automotive protocols

CAN FD/XL decoding			
Protocol configuration	signal type	CAN H, CAN L	
	bit rate		
	nominal bit rate	100 kbps to 1 Mbps	
	FD data rate	100 kbps to 15 Mbps	
	XL data rate	100 kbps to 15 Mbps	
	sampling point	30 % to 90 % within bit period;	
		independent settings for nominal bit rate, FD data rate and XL data rate	
	device list	associate frame identifier with symbolic ID, load DBC file content	
Trigger	source	any input channel or logical channel	
	trigger event setup	start of frame, frame type, identifier,	
		identifier + data, error condition (any	
		combination of CRC error, bit stuffing	
		error, form error and ACK error)	
	identifier setup	identifier type (standard or extended);	
		condition =, ≠, ≥, ≤, in range, out of range	
	FD bits	FDF, BRS and ESI (0, 1, X)	
	XL setup	SDT, VCID, AF; condition =, ≠, ≥, ≤, in range, out of range	
	data setup	data pattern up to 8 byte (hex, decimal, octal, binary or ASCII); condition =, ≠	
Decode	source	any input channel, logical channel	
	display type	decoded bus, tabulated list	
	color coding	start of frame, identifier, DLC, ADS, SDT	
		VCID, AF, data payload, CRC, end of	
		frame, error frame, overload frame, CRC error, bit stuffing error	
	data format	hex, decimal, octal, binary, ASCII, symbolic	

LIN decoding		
Protocol configuration	version	1.3, 2.x or SAE J602; mixed traffic is supported
	bit rate	1 kbps to 20 Mbps
Trigger	source	any input channel or logical channel
	trigger event setup	start of frame (sync break), identifier,
		identifier + data, wake-up frame, error
		condition (any combination of checksum
		error, parity error and sync field error)
	identifier setup	range from 0d to 63d; condition =, \neq , \geq , \leq ,
		in range, out of range
	data setup	data pattern up to 8 byte (hex, decimal,
		octal, binary or ASCII); condition =, ≠
Decode	source	any input channel, logical channel
	display type	decoded bus, tabulated list
	color coding	frame, frame identifier, data payload,
		checksum, error condition
	data format	hex, decimal, octal, binary, ASCII

Ordering information

Designation R&S®MXO 5 Series, base models	Туре	Order No.
Oscilloscope, 350 MHz, 4 channels	R&S®MXO 54	1802.1008K04
Oscilloscope, 100 MHz, 8 channels	R&S®MXO 58	1802.1008K08
Base unit (including standard accessories: 700 MHz passive probe (10:1) per channe		
power cord)	n, accessories bag, quien	otart galas,
Choose your bandwidth upgrade		
Upgrade of R&S®MXO 54 to 500 MHz bandwidth	R&S®MXO5-B245	1802.0676.02
Upgrade of R&S®MXO 54 to 1 GHz bandwidth	R&S®MXO5-B2410	1802.0682.02
Upgrade of R&S®MXO 54 to 2 GHz bandwidth	R&S®MXO5-B2420	1802.0699.02
Upgrade of R&S®MXO 58 to 200 MHz bandwidth	R&S®MXO5-B282	1802.0701.02
Upgrade of R&S®MXO 58 to 350 MHz bandwidth	R&S®MXO5-B283	1802.0718.02
Upgrade of R&S®MXO 58 to 500 MHz bandwidth	R&S®MXO5-B285	1802.0724.02
Upgrade of R&S®MXO 58 to 1 GHz bandwidth	R&S®MXO5-B2810	1802.0730.02
Upgrade of R&S®MXO 58 to 2 GHz bandwidth	R&S®MXO5-B2820	1802.0747.02
Choose your options		
Mixed signal option for R&S®MXO 5 Series with 16 digital channels	R&S®MXO5-B1	1802.0660.02
Arbitrary waveform generator, 100 MHz, 2 analog channels	R&S®MXO5-B6	1802.0753.02
Additional M.2 SSD	R&S®MXO5-B19	1803.0205.02
Memory option 1 Gpoints	R&S®MXO5-B110	1803.0211.02
Low speed serial triggering and decoding (I ² C/SPI/UART/RS-232/RS-422/RS-485)	R&S®MXO5-K510	1802.1243.02
Automotive serial triggering and decoding (CAN/CAN FD/CAN XL/LIN)	R&S®MXO5-K520	1802.1920.02
Power analysis	R&S®MXO5-K31	1802.0799.02
Frequency response analysis	R&S®MXO5-K36	1802.1943.02
Application bundle, consists of the following options:	R&S®MXO5-PK1	1803.0257.02
R&S®MXO5-K510, R&S®MXO5-K520, R&S®MXO5-K31, R&S®MXO5-K36,		
R&S®MXO5-B6		
Choose your additional probes		
Single-ended passive probes		
700 MHz, 10 MΩ, 10:1, 400 V, 9.5 pF, 2.5 mm	R&S®RT-ZP11	1803.0005.02
500 MHz, 10 MΩ, 10:1, 400 V, 9.5 pF, 2.5 mm	R&S®RT-ZP10	1409.7550.00
500 MHz, 10 MΩ, 10:1, 300 V, 10 pF, 5 mm	R&S®RT-ZP05S	1333.2401.02
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm	R&S®RT-ZP1X	1333.1370.02
Active broadband probes: single-ended		
1.0 GHz, 10:1, 1 MΩ, BNC interface	R&S®RT-ZS10L	1333.0815.02
1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface	R&S®RT-ZS10E	1418.7007.02
1.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button,	R&S®RT-ZS10	1410.4080.02
Rohde & Schwarz probe interface		
1.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button,	R&S®RT-ZS20	1410.3502.02
Rohde & Schwarz probe interface		
Active broadband probes: differential		
1.0 GHz, active, differential, 1 M Ω , R&S®ProbeMeter, micro button,	R&S®RT-ZD10	1410.4715.02
incl. 10:1 external attenuator, 1 MΩ, 70 V DC, 46 V AC (peak),		
Rohde & Schwarz probe interface	DA 00DT 7000	1110 1100 00
1.5 GHz, active, differential, 1 M Ω , R&S [®] ProbeMeter, micro button,	R&S®RT-ZD20	1410.4409.02
Rohde & Schwarz probe interface		
Power rail probe	DA ORDT ZDDOO	1000 5000 00
2.0 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface	R&S®RT-ZPR20	1800.5006.02
High voltage probes: passive	DOCRDT 71100	4000 0070 00
250 MHz, 100:1, 100 MΩ, 850 V, 6.5 pF	R&S®RT-ZH03	1333.0873.02
400 MHz, 100:1, 50 MΩ, 1000 V, 7.5 pF	R&S®RT-ZH10	1409.7720.02
400 MHz, 1000:1, 50 MΩ, 1000 V, 7.5 pF	R&S®RT-ZH11	1409.7737.02
High voltage probes: differential	DOCRDT ZUDAZ	4000 0007 00
200 MHz, 250:1/25:1, 5 MΩ, 750 V (peak), 300 V CAT III,	R&S®RT-ZHD07	1800.2307.02
Rohde & Schwarz probe interface	DOCRDT 7UD45	4000 0407 00
100 MHz, 500:1/50:1, 10 MΩ, 1500 V (peak), 1000 V CAT III,	R&S®RT-ZHD15	1800.2107.02
Rohde & Schwarz probe interface	DOORDT 7115 12	4000 0007 00
200 MHz, 500:1/50:1, 10 MΩ, 1500 V (peak), 1000 V CAT III,	R&S®RT-ZHD16	1800.2207.02
Rohde & Schwarz probe interface	DOORDT 711500	4000 0007 00
100 MHz, 1000:1/100:1, 40 MΩ, 6000 V (peak), 1000 V CAT III,	R&S®RT-ZHD60	1800.2007.02
Rohde & Schwarz probe interface		

Designation	Туре	Order No.
Current probes		
20 kHz, AC/DC, 0.01 V/A and 0.001 V/A, ±200 A and ±2000 A, BNC interface	R&S®RT-ZC02	1333.0850.02
100 kHz, AC/DC, 0.1 V/A, 30 A, BNC interface	R&S®RT-ZC03	1333.0844.02
2 MHz, AC/DC, 0.01 V/A, 500 A (RMS), Rohde & Schwarz probe interface	R&S®RT-ZC05B	1409.8204.02
10 MHz, AC/DC, 0.01 V/A, 150 A (RMS), BNC interface	R&S®RT-ZC10	1409.7750K02
10 MHz, AC/DC, 0.01 V/A, 150 A (RMS), Rohde & Schwarz probe interface	R&S®RT-ZC10B	1409.8210.02
50 MHz, AC/DC, 0.1 V/A, 30 A (RMS), Rohde & Schwarz probe interface	R&S®RT-ZC15B	1409.8227.02
100 MHz, AC/DC, 0.1 V/A, 30 A (RMS), BNC interface	R&S®RT-ZC20	1409.7766K02
100 MHz, AC/DC, 0.1 V/A, 30 A (RMS), Rohde & Schwarz probe interface	R&S®RT-ZC20B	1409.8233.02
120 MHz, AC/DC, 1 V/A, 5 A (RMS), BNC interface	R&S®RT-ZC30	1409.7772K02
EMC near-field probe		
Probe set for E and H near-field measurements, 30 MHz to 3 GHz	R&S®HZ-15	1147.2736.02
Logic probe ¹⁰		
400 MHz logic probe, 8 channels	R&S®RT-ZL04	1333.0721.02
Probe accessories		
Accessory set for R&S®RT-ZP11 passive probe (2.5 mm probe tip)	R&S®RT-ZA1	1409.7566.00
Probe power supply for R&S®RT-ZC10/-ZC20/-ZC30	R&S®RT-ZA13	1409.7789.02
External attenuator 10:1, 2.0 GHz, 1.3 pF, 60 V DC,	R&S®RT-ZA15	1410.4744.02
42.4 V AC (peak), for R&S®RT-ZD20/-ZD30 probes		
Probe pouch for the logic probes	R&S®RT-ZA19	1335.7875.02
Power deskew and calibration test fixture	R&S®RT-ZF20	1800.0004.02
3D positioner with central tensioning knob for easy clamping and positioning of	R&S®RT-ZA1P	1326.3641.02
probes (span width: 200 mm, clamping range: 15 mm)		
Bipod probe positioner	R&S®RT-ZA29	1801.4803.02
Choose your accessories		
Rackmount kit, for R&S®MXO 5 Series with 8 HU	R&S®ZZA-MXO5	1802.3181.02
Front cover	R&S®MXO5-Z1	1803.0240.02
Soft case (W × H × D: 550 mm × 300 mm × 340 mm)	R&S®MXO5-Z3	1803.0228.02
Transit case (W × H × D: 613 mm × 478 mm × 337 mm)	R&S®MXO5-Z4	1803.0234.02
VESA adapter	R&S®MXO5-Z7	1803.0457.02
VESA mount (compatible with standard 100 mm × 100 mm pattern)	Choose industry standard mounts	
	according to FDMI MIS-D, up to 14 kg with	
	M4x10 screws	

 $^{^{10}\,}$ The R&S®MXO5-B1 mixed signal option contains two R&S®RT-ZL04 logic probes.

Warranty		
Base unit		1 year
All other items ¹¹		1 year
Options		
Extended warranty, one year	R&S®WE1	Contact your local
Extended warranty, two years	R&S®WE2	Rohde & Schwarz sales office.
Extended warranty with calibration coverage, one year R&S®CW1		
Extended warranty with calibration coverage, two years R&S®CW2		
Extended warranty with accredited calibration coverage, R&S®AW1		
one year		
Extended warranty with accredited calibration coverage,	R&S®AW2	
two years		

Extended warranty with a term of one and two years (WE1 and WE2)

Repairs carried out during the contract term are free of charge ¹². Necessary calibration and adjustments carried out during repairs are also covered.

Extended warranty with calibration coverage (CW1 and CW2)

Enhance your extended warranty by adding calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated, inspected and maintained during the term of the contract. It includes all repairs ¹² and calibration at the recommended intervals as well as any calibration carried out during repairs or option upgrades.

Extended warranty with accredited calibration (AW1 and AW2)

Enhance your extended warranty by adding accredited calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated under accreditation, inspected and maintained during the term of the contract. It includes all repairs ¹² and accredited calibration at the recommended intervals as well as any accredited calibration carried out during repairs or option upgrades.

The terms HDMI and HDMI High-Definition Multimedia Interface, and the HDMI Logo are trademarks or registered trademarks of HDMI Licensing, LLC in the United States and other countries.

¹¹ For options installed, the remaining base unit warranty applies if longer than 1 year. Exception: all batteries have a 1 year warranty.

¹² Excluding defects caused by incorrect operation or handling and force majeure. Wear-and-tear parts are not included.

Version 03.00, October 2023

Service at Rohde & Schwarz You're in great hands

- ➤ Worldwide
- Local and personalized

- Customized and flexibleUncompromising qualityLong-term dependability



Mess- und Prüftechnik. Die Experten.

Ihr Ansprechpartner / Your Partner:

dataTec AG

E-Mail: info@datatec.eu >>> www.datatec.eu

Rohde & Schwarz

The Rohde & Schwarz technology group is among the trailblazers when it comes to paving the way for a safer and connected world with its leading solutions in test&measurement, technology systems and networks & cybersecurity. Founded more than 85 years ago, the group is a reliable partner for industry and government customers around the globe. The independent company is headquartered in Munich, Germany and has an extensive sales and service network with locations in more than 70 countries.

www.rohde-schwarz.com

Sustainable product design

- ► Environmental compatibility and eco-footprint
- ► Energy efficiency and low emissions
- ► Longevity and optimized total cost of ownership

Certified Quality Management ISO 9001

Certified Environmental Management

ISO 14001

Rohde & Schwarz training

www.training.rohde-schwarz.com

Rohde & Schwarz customer support

www.rohde-schwarz.com/support



